

<b>Notice of References Cited</b>	Application/Control No. 10/649,508	Applicant(s)/Patent Under Reexamination WIEDEMAN ET AL.	
	Examiner Tri H. Phan	Art Unit 2661	Page 1 of 1

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	C	US-6,167,052 A	12-2000	McNeill et al.	370/399
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	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Kok et al., "Simple IP Subnet VLAN Implementation", January 2001, Faculty of Information Technology, CyberJaya, Malaysia, IEEE, 1531-2216/01, pages 160-165.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.